New Jersey Semi-Conductor Products, Inc.

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BLW86

HF/VHF power transistor

DESCRIPTION

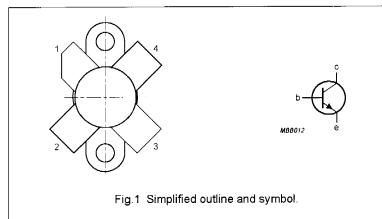
N-P-N silicon planar epitaxial transistor intended for use in class-A, AB and B operated h.f. and v.h.f. transmitters with a nominal supply voltage of 28 V. The transistor is resistance stabilized and is guaranteed to withstand severe load mismatch conditions. Matched h_{FE} groups are available on request. It has a 3/8" flange envelope with a ceramic cap. All leads are isolated from the flange.

QUICK REFERENCE DATA

R.F. performance up to $T_h = 25 \ ^{\circ}C$

MODE OF OPERATION	V _{CE} V	f MHz	PL W	G _p dB	ղ %	z _i Ω	Υ _L mS	d ₃ dB
c.w. (class-B)	28	175	45	> 7,5	> 70	0,7 + j1,3	110 – j62	_
s.s.b. (class-AB)	28	1,6 – 28	5–47,5 (P.E.P.)	typ. 19	typ. 45		-	typ. –30
s.s.b. (class-A)	26	1,6 – 28	17 (P.E.P.)	typ. 22	-	_		typ. –42

PIN CONFIGURATION



PINNING - SOT123

PIN	DESCRIPTION
1	collector
2	emitter
3	base
4	emitter



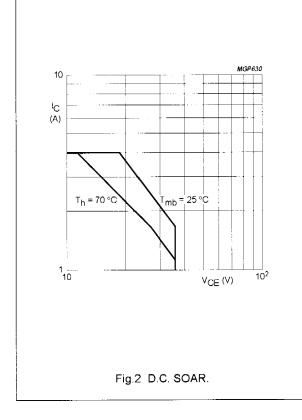
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Quality Semi-Conductors

HF/VHF power transistor

RATINGS

Limiting values in accordance with the Absolute Maximum Syste	m (IEC 134)		
Collector-emitter voltage (V _{BE} = 0)			
peak value	VCESM	max.	65 V
Collector-emitter voltage (open base)	V _{CEO}	max.	36 V
Emitter-base voltage (open-collector)	V _{EBO}	max.	4 V
Collector current (average)	I _{C(AV)}	max.	4 A
Collector current (peak value); f > 1 MHz	I _{CM}	max.	12 A
R.F. power dissipation (f > 1 MHz); T_{mb} = 25 $^\circ$ C	P _{rf}	max.	105 W
Storage temperature	T _{stg}	–65 to	o + 150 °C
Operating junction temperature	Tj	max.	200 °C



MGP631 150 Prf (W) 100 III derate by 0.58 W/K 11 0.43 W/K 50 ſ 0 0 50 100 T_h (°C) E Continuous d.c. operation II Continuous r.f. operation III Short-time operation during mismatch Fig.3 R.F. power dissipation; $V_{CE} \le 28$ V; f > 1 MHz.

THERMAL RESISTANCE

(dissipation = 45 W; T_{mb} = 83,5 °C, i.e. T_h = 70 °C)

From junction to mounting base (d.c. dissipation) From junction to mounting base (r.f. dissipation) From mounting base to heatsink

R _{th j-mb(dc)}	=	2,65 K/W
R _{th j-mb(rf)}	=	1,95 K/W
R _{th mb-h}	=	0,3 K/W

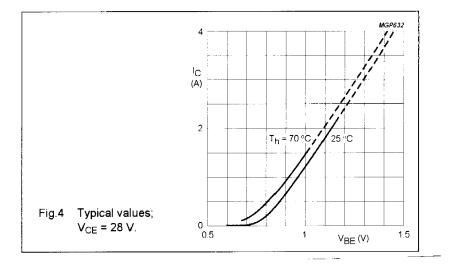
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HF/VHF power transistor

CHARACTERISTICS				
$T_j = 25 \ ^{\circ}C$ unless otherwise specified				
Collector-emitter breakdown voltage				
$V_{BE} = 0$; I _C = 25 mA	V _{(BR)CES}	>	65	V
Collector-emitter breakdown voltage				
open base; I _C = 100 mA	V _{(BR)CEO}	>	36	V
Emitter-base breakdown voltage				
open collector; I _E = 10 mA	V _{(BR)EBO}	>	4	V
Collector cut-off current				
V_{BE} = 0; V_{CE} = 36 V	ICES	<	10	mA
Second breakdown energy; L = 25 mH; f = 50 Hz				
open base	E _{SBO}	>		mJ
R_{BE} = 10 Ω	E _{SBR}	>	8	mJ
D.C. current gain ⁽¹⁾				
$I_{\rm C}$ = 2,5 A; $V_{\rm CE}$ = 5 V	hee	typ.	45	
	h _{FE}		45 to 80	
I_{C} = 2,5 A; V_{CE} = 5 V D.C. current gain ratio of matched devices ⁽¹⁾			to 80	
	h _{FE} h _{FE1} /h _{FE2}			
D.C. current gain ratio of matched devices ⁽¹⁾	h _{FE1} /h _{FE2}	10	to 80 1,2	
D.C. current gain ratio of matched devices ⁽¹⁾ I_{C} = 2,5 A; V _{CE} = 5 V		10	to 80	V
D.C. current gain ratio of matched devices ⁽¹⁾ $I_{C} = 2,5 \text{ A}; V_{CE} = 5 \text{ V}$ Collector-emitter saturation voltage ⁽¹⁾	h _{FE1} /h _{FE2} V _{CEsat}	10 <	to 80 1,2 1,5	
D.C. current gain ratio of matched devices ⁽¹⁾ $I_C = 2,5 A; V_{CE} = 5 V$ Collector-emitter saturation voltage ⁽¹⁾ $I_C = 7,5 A; I_B = 1,5 A$ Transition frequency at f = 100 MHz ⁽¹⁾ $-I_E = 2,5 A; V_{CB} = 28 V$	h _{FE1} /h _{FE2} V _{CEsat} f _T	10 <	to 80 1,2 1,5 570	MHz
D.C. current gain ratio of matched devices ⁽¹⁾ $I_C = 2,5 \text{ A}; V_{CE} = 5 \text{ V}$ Collector-emitter saturation voltage ⁽¹⁾ $I_C = 7,5 \text{ A}; I_B = 1,5 \text{ A}$ Transition frequency at f = 100 MHz ⁽¹⁾	h _{FE1} /h _{FE2} V _{CEsat}	10 < typ	to 80 1,2 1,5 570	
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D.C. current gain ratio of matched devices ⁽¹⁾ $I_C = 2,5 A; V_{CE} = 5 V$ Collector-emitter saturation voltage ⁽¹⁾ $I_C = 7,5 A; I_B = 1,5 A$ Transition frequency at f = 100 MHz ⁽¹⁾ $-I_E = 2,5 A; V_{CB} = 28 V$ $-I_E = 7,5 A; V_{CB} = 28 V$ Collector capacitance at f = 1 MHz $I_E = I_e = 0; V_{CB} = 28 V$	h _{FE1} /h _{FE2} V _{CEsat} f _T f _T	10 < typ. typ. typ.	to 80 1,2 1,5 570 570 82 54	MHz MHz

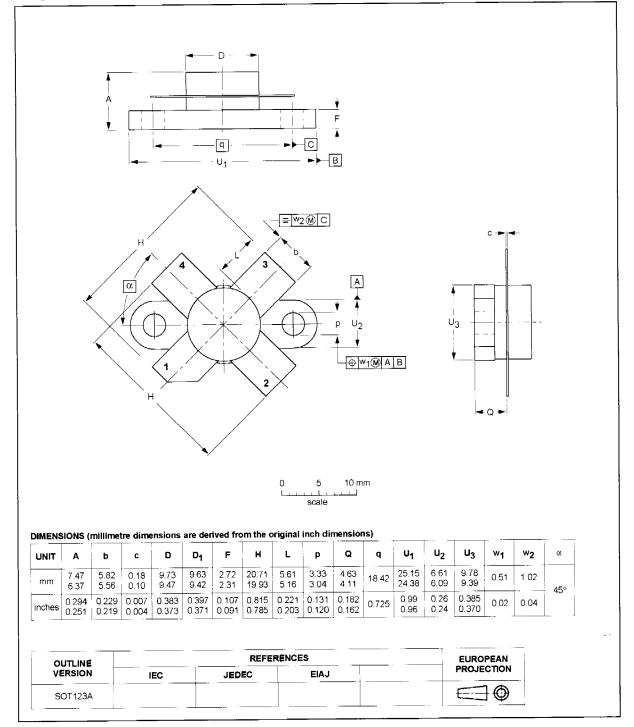
Note

1. Measured under pulse conditions: $t_p \le 200 \ \mu s; \ \delta \le 0,02.$



PACKAGE OUTLINE

Flanged ceramic package; 2 mounting holes; 4 leads



BLW86

SOT123A